International
IOR Rectifier

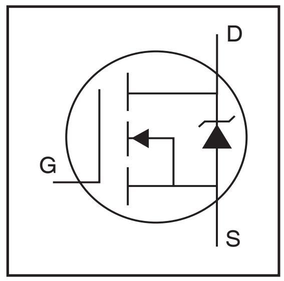
DIGITAL AUDIO MOSFET

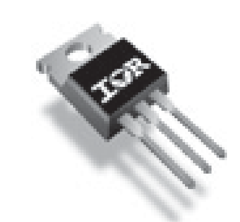
IRFB4103PbF

Features

- Key parameters optimized for Class-D audio amplifier applications
- Low R_{DSON} for improved efficiency
- Low Q_G and Q_{SW} for better THD and improved efficiency
- Low Q_{RR} for better THD and lower EMI
- 175°C operating junction temperature for ruggedness
- Can deliver up to 300W per channel into 8Ω load in half-bridge topology

Key Parameters		
V_{DS}	200	V
$R_{DS(ON)}$ typ. @ 10V	139	mΩ
Q_g typ.	25	nC
Q_{sw} typ.	15	nC
$R_{G(int)}$ typ.	1.0	Ω
T_J max	175	°C





TO-220AB

Description

This Digital Audio MOSFET is specifically designed for Class-D audio amplifier applications. This MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area. Furthermore, Gate charge, body-diode reverse recovery and internal Gate resistance are optimized to improve key Class-D audio amplifier performance factors such as efficiency, THD and EMI. Additional features of this MOSFET are 175°C operating junction temperature and repetitive avalanche capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for ClassD audio amplifier applications.

Absolute Maximum Ratings

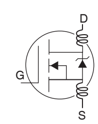
	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	200	V
V_{GS}	Gate-to-Source Voltage	±30	
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 10V	17	A
I_D @ T_C = 100°C	Continuous Drain Current, V_{GS} @ 10V	12	
I_{DM}	Pulsed Drain Current ①	68	
P_D @T_C = 25°C	Power Dissipation ④	140	W
P_D @T_C = 100°C	Power Dissipation ④	71	
	Linear Derating Factor	0.95	W/°C
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ④	——	1.05	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50	——	
$R_{\theta JA}$	Junction-to-Ambient ④	——	62	

Notes ① through ⑤ are on page 2

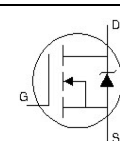
Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	200	–––	–––	V	V_{GS} = 0V, I_D = 250μA
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	–––	0.21	–––	V/°C	Reference to 25°C, I_D = 1mA
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	–––	139	165	mΩ	V_{GS} = 10V, I_D = 12A ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0	–––	5.5	V	V_{DS} = V_{GS}, I_D = 250μA
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient	–––	-13	–––	mV/°C	
I_{DSS}	Drain-to-Source Leakage Current	–––	–––	25	μA	V_{DS} = 200V, V_{GS} = 0V
		–––	–––	250		V_{DS} = 200V, V_{GS} = 0V, T_J = 125°C
I_{GSS}	Gate-to-Source Forward Leakage	–––	–––	100	nA	V_{GS} = 30V
	Gate-to-Source Reverse Leakage	–––	–––	-100		V_{GS} = -30V
g_{fs}	Forward Transconductance	7.1	–––	–––	S	V_{DS} = 50V, I_D = 12A
Q_g	Total Gate Charge	–––	25	38	nC	
Q_{gs1}	Pre-Vth Gate-to-Source Charge	–––	5.4	–––		V_{DS} = 160V
Q_{gs2}	Post-Vth Gate-to-Source Charge	–––	2.9	–––		V_{GS} = 10V
Q_{gd}	Gate-to-Drain Charge	–––	12	–––		I_D = 12A
Q_{godr}	Gate Charge Overdrive	–––	4.7	–––		See Fig. 6 and 19
Q_{sw}	Switch Charge (Q_{gs2} + Q_{gd})	–––	15	–––		
$R_{G(int)}$	Internal Gate Resistance	–––	1.0	–––	Ω	
$t_{d(on)}$	Turn-On Delay Time	–––	9.6	–––	ns	V_{DD} = 100V, V_{GS} = 10V ③
t_r	Rise Time	–––	40	–––		I_D = 12A
$t_{d(off)}$	Turn-Off Delay Time	–––	16	–––		R_G = 2.5Ω
t_f	Fall Time	–––	5.4	–––		
C_{iss}	Input Capacitance	–––	900	–––	pF	V_{GS} = 0V
C_{oss}	Output Capacitance	–––	120	–––		V_{DS} = 50V
C_{rss}	Reverse Transfer Capacitance	–––	22	–––		f = 1.0MHz, See Fig.5
C_{oss}	Effective Output Capacitance	–––	150	–––		V_{GS} = 0V, V_{DS} = 0V to 160V
L_D	Internal Drain Inductance	–––	4.5	–––	nH	Between lead, 6mm (0.25in.)
L_S	Internal Source Inductance	–––	7.5	–––		from package and center of die contact 

Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy②	–––	130	mJ
I_{AR}	Avalanche Current ⑤	See Fig. 14, 15, 17a, 17b		A
E_{AR}	Repetitive Avalanche Energy ⑤			mJ

Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S @ T_C = 25°C	Continuous Source Current (Body Diode)	–––	–––	17	A	MOSFET symbol showing the
I_{SM}	Pulsed Source Current (Body Diode) ①	–––	–––	68		integral reverse p-n junction diode. 
V_{SD}	Diode Forward Voltage	–––	–––	1.7	V	T_J = 25°C, I_S = 10A, V_{GS} = 0V ③
t_{rr}	Reverse Recovery Time	–––	130	200	ns	T_J = 25°C, I_F = 12A
Q_{rr}	Reverse Recovery Charge	–––	730	110	nC	di/dt = 100A/μs ③

Notes:

① Repetitive rating; pulse width limited by max. junction temperature.
② Starting T_J = 25°C, L = 1.78mH, R_G = 25Ω, I_{AS} = 12A.
③ Pulse width ≤ 400μs; duty cycle ≤ 2%.
④ R_θ is measured at T_J of approximately 90°C.
⑤ Limited by Tjmax. See Figs. 14, 15, 17a, 17b for repetitive avalanche information

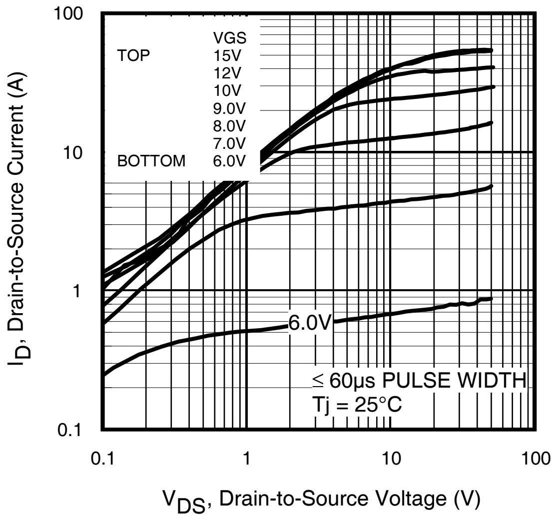


Fig 1. Typical Output Characteristics

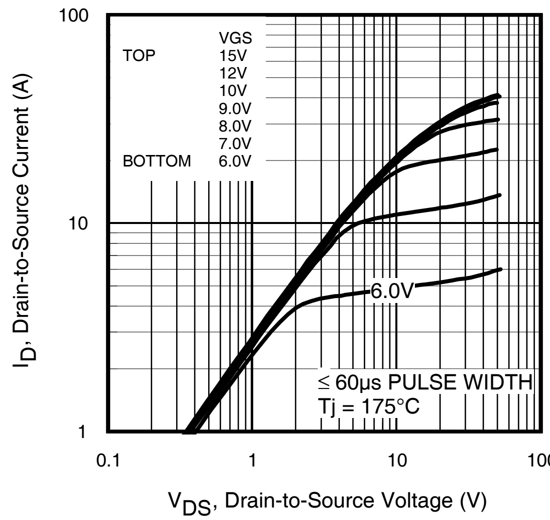


Fig 2. Typical Output Characteristics

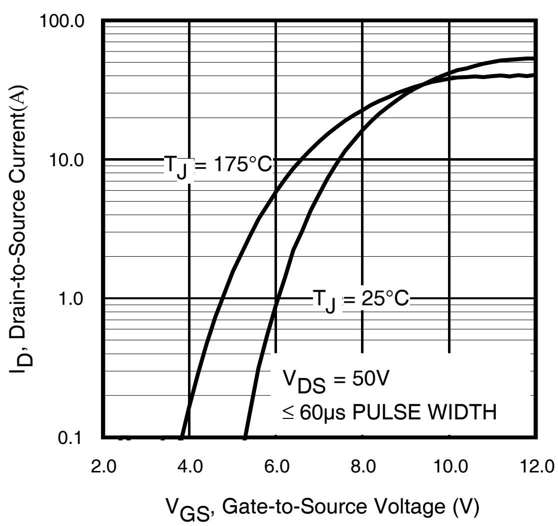


Fig 3. Typical Transfer Characteristics

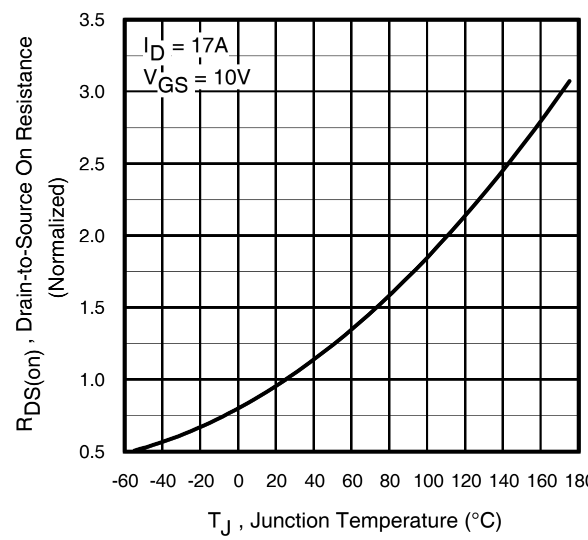


Fig 4. Normalized On-Resistance vs. Temperature

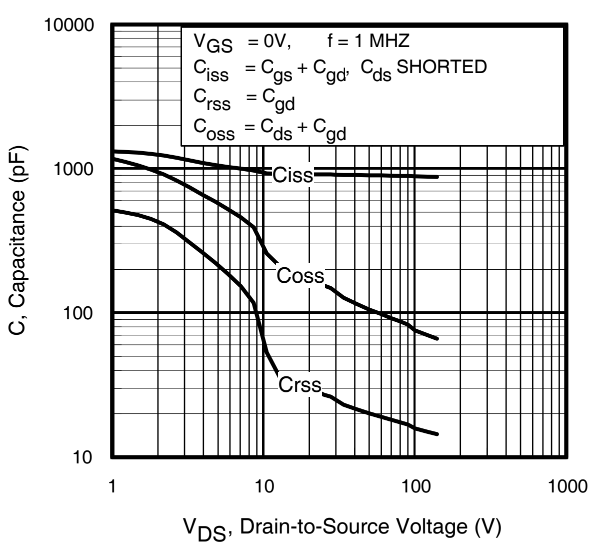


Fig 5. Typical Capacitance vs.Drain-to-Source Voltage

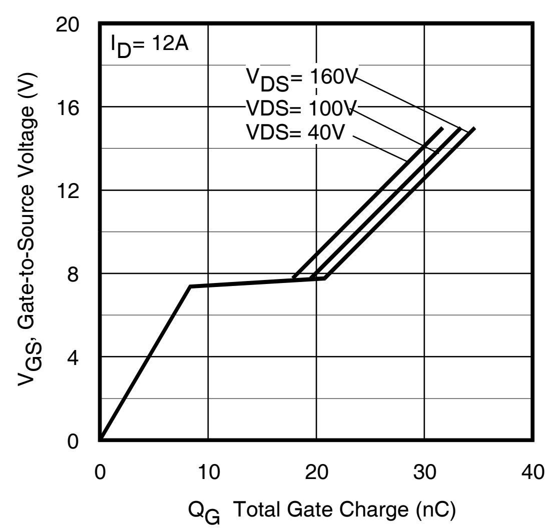


Fig 6. Typical Gate Charge vs.Gate-to-Source Voltage

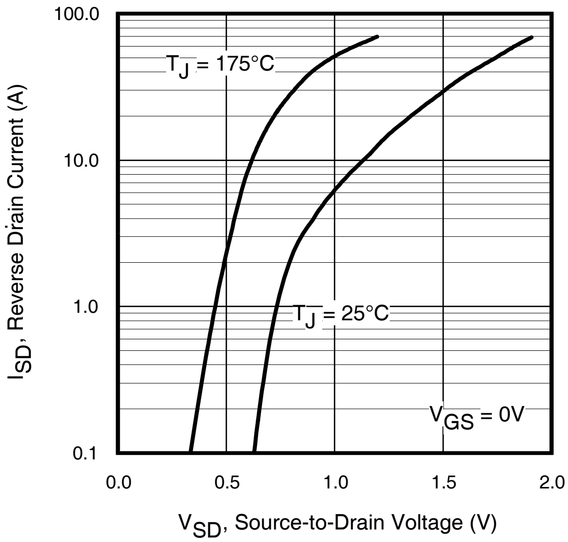


Fig 7. Typical Source-Drain Diode Forward Voltage

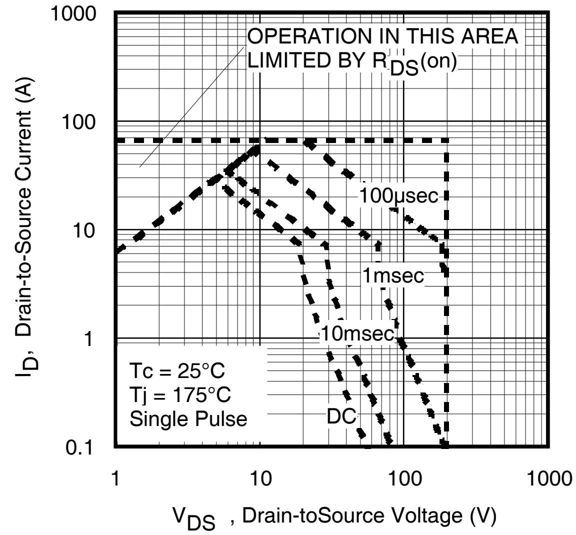


Fig 8. Maximum Safe Operating Area

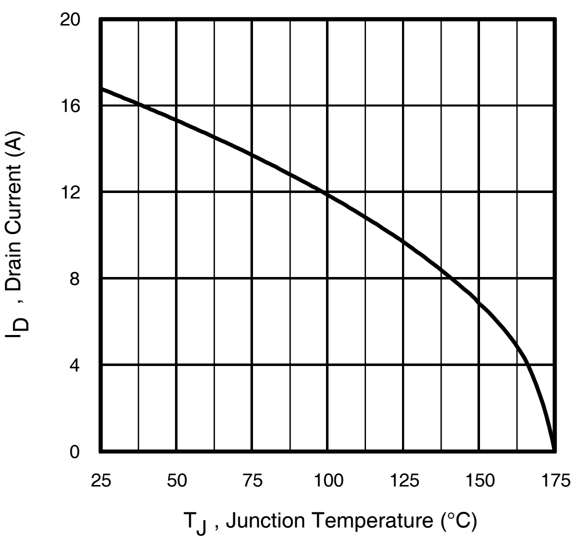


Fig 9. Maximum Drain Current vs. Case Temperature

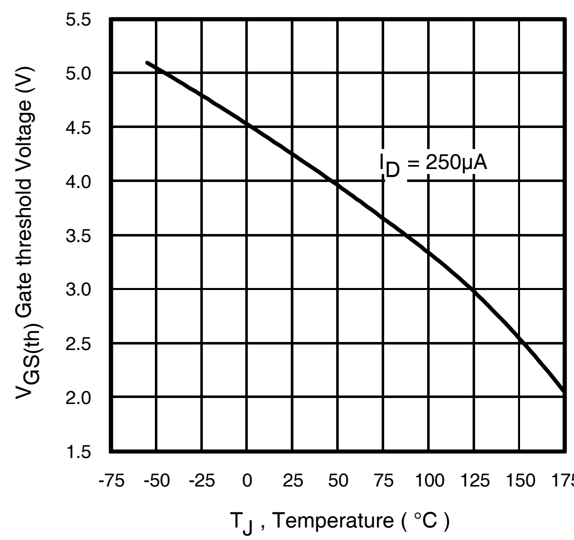
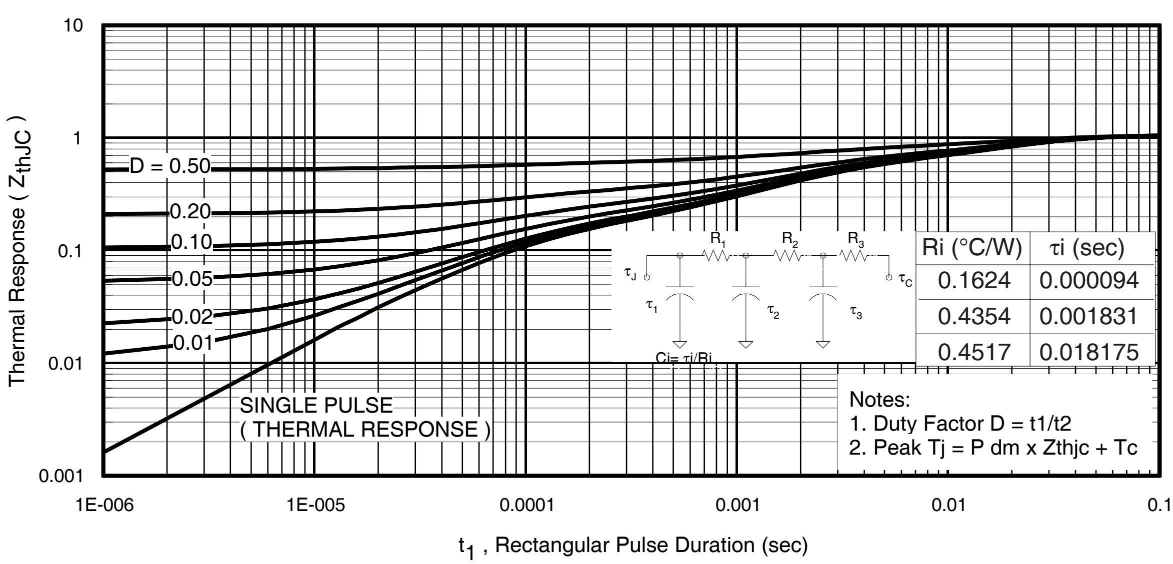


Fig 10. Threshold Voltage vs. Temperature



Ri (°C/W)	τi (sec)
0.1624	0.000094
0.4354	0.001831
0.4517	0.018175

Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

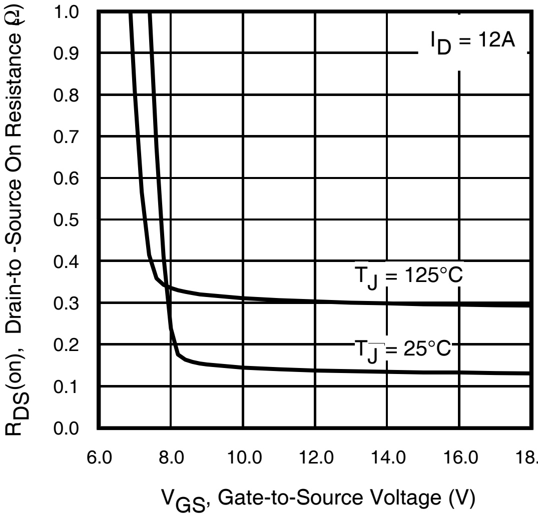


Fig 12. On-Resistance Vs. Gate Voltage

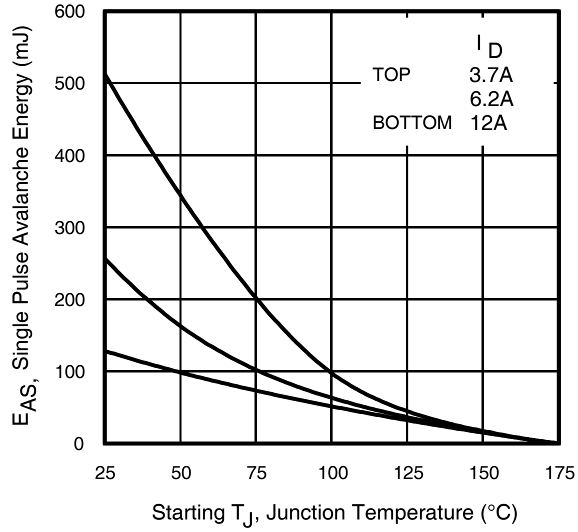


Fig 13. Maximum Avalanche Energy Vs. Drain Current

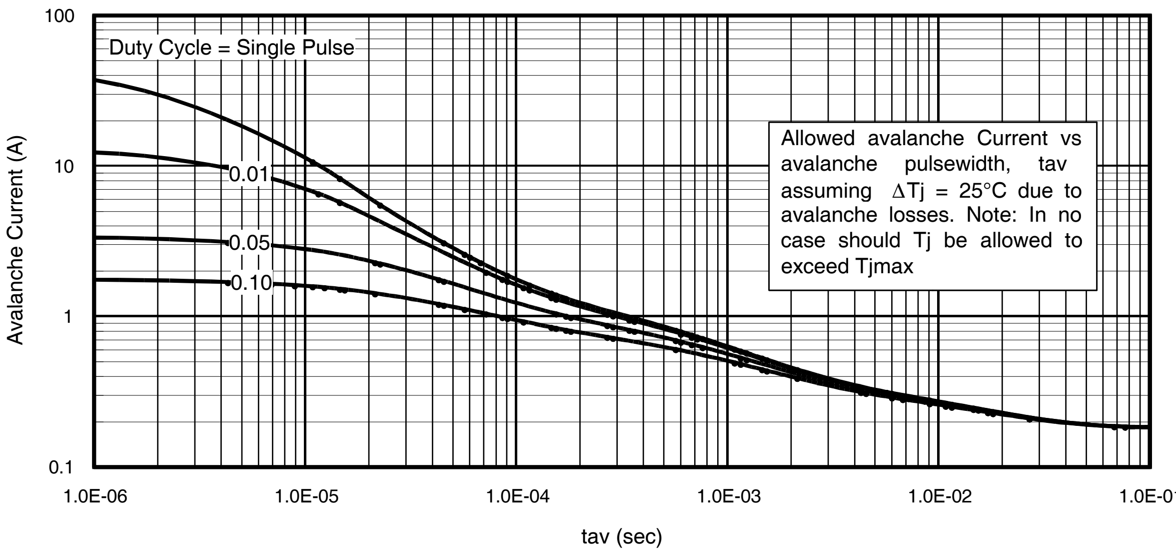


Fig 14. Typical Avalanche Current Vs.Pulsewidth

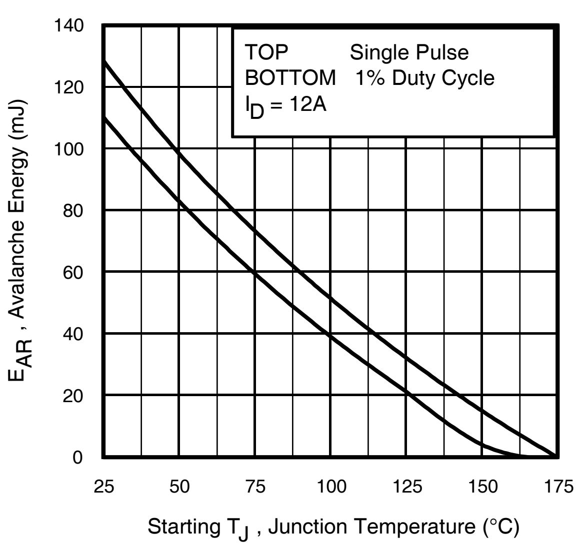


Fig 15. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15:
(For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 17a, 17b.
4. $P_{D\ (ave)}$ = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6. I_{av} = Allowable avalanche current.
7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
   t_{av} = Average time in avalanche.
   D = Duty cycle in avalanche = $t_{av} \cdot f$
   $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$P_{D\ (ave)} = 1/2\ (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$
$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$
$$E_{AS\ (AR)} = P_{D\ (ave)} \cdot t_{av}$$

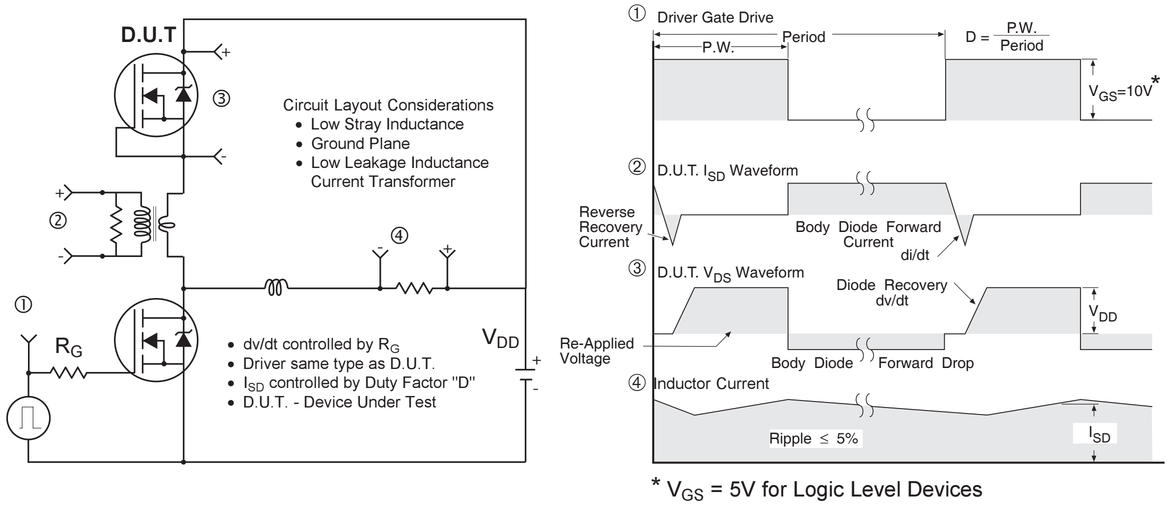


Fig 16. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

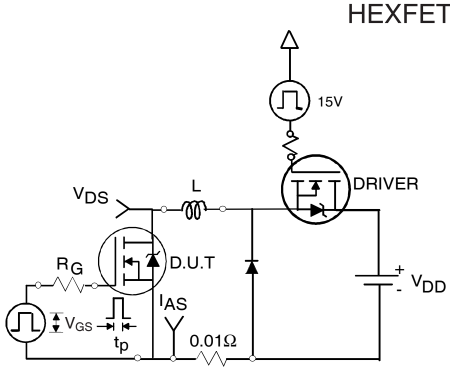


Fig 17a. Unclamped Inductive Test Circuit

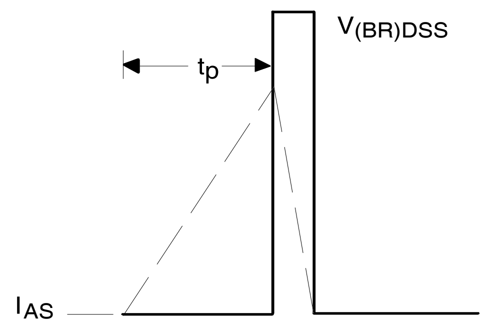


Fig 17b. Unclamped Inductive Waveforms

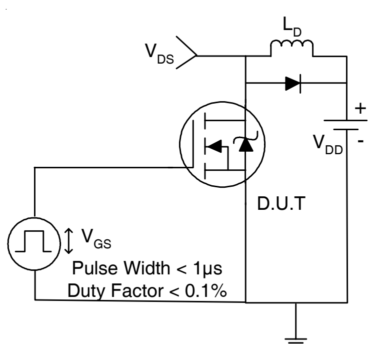


Fig 18a. Switching Time Test Circuit

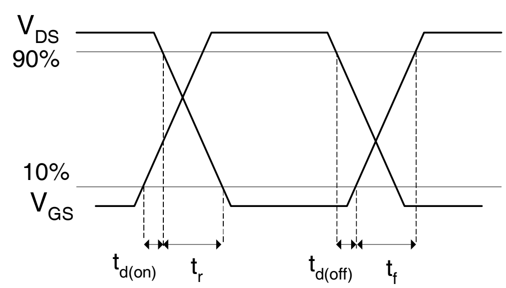


Fig 18b. Switching Time Waveforms

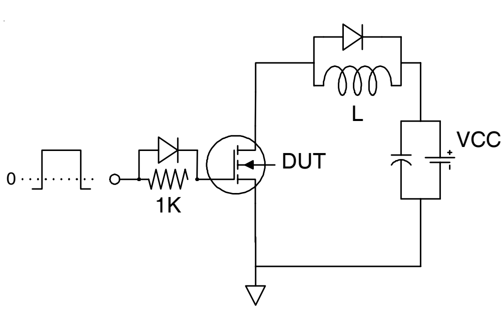


Fig 19a. Gate Charge Test Circuit

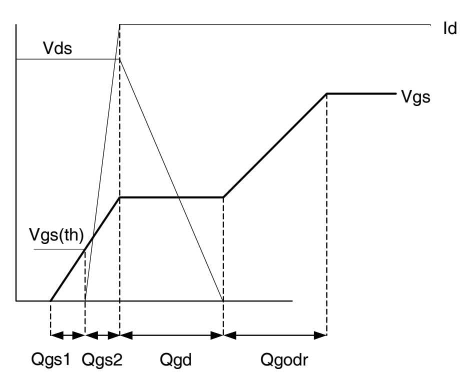
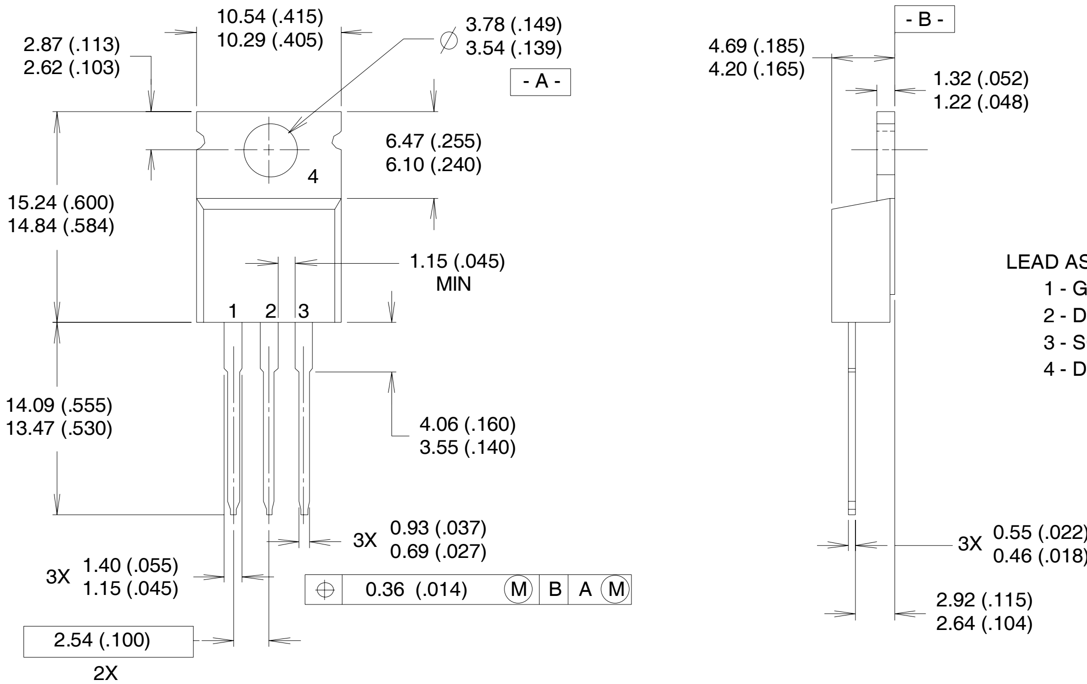


Fig 19b Gate Charge Waveform

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



LEAD ASSIGNMENTS
1 - GATE
2 - DRAIN
3 - SOURCE
4 - DRAIN

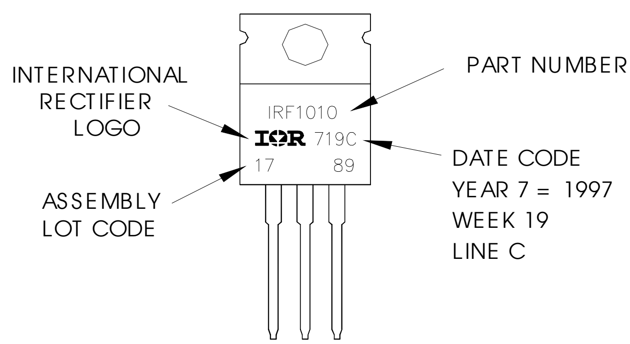
NOTES:

1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
2 CONTROLLING DIMENSION : INCH
3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
LOT CODE 1789
ASSEMBLED ON WW 19, 1997
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



TO-220AB packages are not recommended for Surface Mount Application.

Data and specifications subject to change without notice.
This product has been designed and qualified for the Industrial market.
Qualification Standards can be found on IR's Web site.

International
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IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
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Note: For the most current drawings please refer to the IR website at:
http://www.irf.com/package/